

### **Power Block**

### **Features**

- Dual asymmetric N-channel OptiMOS™5 MOSFET
- Logic level (4.5V rated)
- · Optimized for high performance buck converters
- Pb-free lead plating; RoHS compliant
- Qualified according to JEDEC<sup>1)</sup> for target applications
- Halogen-free according to IEC61249-2-21
- Monolithic integrated Schottky like diode





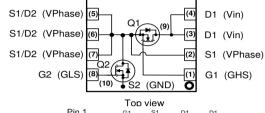


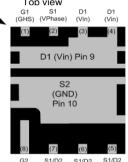
Туре	Package	Marking
BSG0813NDI	PG-TISON8-4	0813NDI

 $\textbf{Maximum ratings,} \text{ at Tj=}25^{\circ}\text{C, unless otherwise specified} \ ^{2)}$ 

### **Product Summary**

		Q1	Q2	
$V_{ t DS}$		25	25	V
$R_{\mathrm{DS(on),max}}$	$R_{\rm DS(on),max}$ $V_{\rm GS}$ =10 V		1.2	mΩ
	V <sub>GS</sub> =4.5 V	4	1.7	
I <sub>D</sub>		50	50	Α





G2 S1/D2 S1/D2 S1/D2 (GLS) (VPhase) (VPhase) (VPhase) Bottom View

Parameter	Symbol	Conditions	Va	lue	Unit
			Q1	Q2	
Continuous drain current	ID	T <sub>C</sub> =70 °C, V <sub>GS</sub> =10 V	50	50	А
		T <sub>C</sub> =70 °C, V <sub>GS</sub> =4.5 V	50	50	
		T <sub>A</sub> =25 °C, V <sub>GS</sub> =4.5 V <sup>3)</sup>	31	50	
		T <sub>A</sub> =25 °C, V <sub>GS</sub> =4.5 V <sup>4)</sup>	19	33	
Pulsed drain current	I <sub>D,pulse</sub>	T <sub>C</sub> =70 °C	160	160	
Avalanche energy, single pulse	E <sub>AS</sub>	Q1: $I_D$ =10 A, Q2: $I_D$ =20 A, $R_{GS}$ =25 $\Omega$	30	90	mJ
Gate source voltage	$V_{GS}$	<i>T</i> <sub>j</sub> =25 °C	±	16	V
Power dissipation	$P_{\text{tot}}$	T <sub>A</sub> =25 °C <sup>3)</sup>	6.25	6.25	W
		T <sub>A</sub> =25 °C <sup>4)</sup>	2.5	2.5	
Operating and storage temperature	$T_{\rm j},~T_{\rm stg}$		-55 150		°C
IEC climatic category; DIN IEC 68-1			55/1	50/56	

<sup>1)</sup> J-STD20 and JESD22



Parameter		Symbol Conditions	Values			Unit	
				min.	typ.	max.	
Thermal characteristics							
Thermal resistance, junction -	Q1	$R_{\mathrm{thJC}}$		-	-	4.3	K/W
case	Q2	1		-	-	2.2	
Thermal resistance, junction - ambient <sup>2)</sup>	Q1 Q2	$R_{thJA}$	Application specific board <sup>3)</sup>	-	-	20	
	Q1		6 cm <sup>2</sup> cooling area <sup>4)</sup>	_	_	50	1
	Q2		o cini cooling area	_	_	30	

**Electrical characteristics,** at  $T_j$ =25 °C, unless otherwise specified

### Static characteristics

Drain-source breakdown voltage	Q1	V <sub>(BB)Dee</sub>	V <sub>GS</sub> =0 V, I <sub>D</sub> =1 mA	25 <sup>6)</sup>	_	_	V
	Q2	, (BR)D33	- GS	25			
Breakdown voltage temperature			$I_{\rm D}$ =10 mA, referenced	-	15	_	mV/K
coefficient	Q2	$/dT_{j}$	to 25 °C		10		111 7/17
Gate threshold voltage	Q1	$V_{\rm GS(th)}$	$V_{\rm DS} = V_{\rm GS}, I_{\rm D} = 250 \mu{\rm A}$	1.2	1.6	2	V
	Q2	▼ GS(th)	ν <sub>DS</sub> – ν <sub>GS</sub> , γ <sub>D</sub> –200 μΑ	1.2	1.0	۷	l v
Zero gate voltage drain current	Q1	IDSS	V <sub>DS</sub> =25 V, V <sub>GS</sub> =0 V,	1	1	1	μΑ
	Q2		<i>T</i> <sub>j</sub> =25 °C	ı	ı	500	
	Q1		V <sub>DS</sub> =20 V, V <sub>GS</sub> =0 V,	ı	-	100	
	Q2		T <sub>j</sub> =125 °C	1	1	-	mA
Gate-source leakage current	Q1	I <sub>GSS</sub>	V <sub>GS</sub> =16 V, V <sub>DS</sub> =0 V			100	nA
	Q2		GS-10 V, V DS-0 V	-	-	100	
Drain-source on-state	Q1	$R_{DS(on)}$	V <sub>GS</sub> =4.5 V, I <sub>D</sub> =20 A	-	3.2	4.0	mΩ
resistance	Q2		V GS-4.5 V, 7D-20 A	1	1.2	1.7	
	Q1		V <sub>GS</sub> =10 V, I <sub>D</sub> =20 A	-	2.4	3.0	
	Q2		GS-10 V, 7D-20 A	1	0.9	1.2	
Gate resistance	Q1	$R_{G}$		-	0.7	1.2	Ω
	Q2			-	1	1.7	
Transconductance	Q1	$g_{fs}$	$ V_{\rm DS}  > 2 I_{\rm D} R_{\rm DS(on)max}$	46	93	-	S
	Q2		I <sub>D</sub> =20 A	70	140	-	

<sup>&</sup>lt;sup>2)</sup> Only one of both transistors active



Parameter		Symbol	Conditions		Values		Unit
				min.	typ.	max.	
Dynamic characteristics							
Input capacitance	Q1	$C_{iss}$		-	780	1100	рF
	Q2			-	2200	2900	
Output capacitance	Q1	Coss	V <sub>GS</sub> =0 V,	-	390	520	
	Q2		$V_{DS} = 12 \text{ V}, f = 1 \text{ MHz}$	-	1300	1700	
Reverse transfer capacitance	Q1	C <sub>rss</sub>		-	38	-	
	Q2			-	71	-	
Turn-on delay time	Q1	$t_{d(on)}$		-	4.3	-	ns
	Q2		$V_{IN}$ =12 V, $V_{DRV}$ =5 V, $F_{SW}$ =500 KHz, $I_{OUT}$ =20 A <sup>5)</sup>	-	3.6	-	
Rise time	Q1	t <sub>r</sub>		-	4.7	-	
	Q2			-	2.8	-	
Turn-off delay time	Q1	$t_{d(off)}$		-	4.3	-	
	Q2			-	5.7	-	
Fall time	Q1	t <sub>f</sub>		-	1.4	-	
	Q2			-	1.7	-	
Gate Charge Characteristics	-		•			-	-
Gate to source charge	Q1	$Q_{gs}$		-	2.0		nC
Gate to drain charge		$Q_{gd}$		-	1.4	-	
Gate charge total		$Q_{g}$		-	5.6	8.4	
Gate plateau voltage		V <sub>plateau</sub>	V <sub>DD</sub> =12 V, V <sub>D</sub> =20 A,	-	2.6	-	٧
Gate to source charge	Q2	$Q_{gs}$	$V_{\rm GS} = 0 \text{ to } 4.5 \text{ V}$	-	5.2	-	nC
Gate to drain charge		$Q_{gd}$		-	3.1	-	
Gate charge total		$Q_{g}$		-	15	22	
Gate plateau voltage		V <sub>plateau</sub>		-	2.3	-	٧
Output charge	Q1		V <sub>DD</sub> =12 V, V <sub>GS</sub> =0 V	-	8	-	nC
	Q2		V DD=12 V, V GS=U V	-	27	-	

<sup>&</sup>lt;sup>3)</sup> 8 Layers copper 70µm thickness. PCB in still air

 $<sup>^{4)}</sup>$  Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm $^2$  (one layer, 70  $\mu$ m thick) copper area for drain connection. PCB is vertical in still air.



Parameter		eter Symbol Conditions	Conditions	Values			Unit
				min.	typ.	max.	
Reverse Diode							
Diode continuous forward current	Q1	Is		-	-	29	Α
	Q2		T <sub>C</sub> =25 °C	-	-	50	
Diode pulse current	Q1	I <sub>S,pulse</sub>	7 <sub>C</sub> -23	-	-	160	
	Q2			-	-	160	
Diode forward voltage	Q1	$oldsymbol{V}_{ extsf{SD}}$	$V_{\rm GS} = 0 \text{ V}, I_{\rm F} = 20 \text{ A},$ $T_{\rm j} = 25 \text{ °C}$	-	0.82	1	V
	Q2		$V_{\rm GS}$ =0 V, $I_{\rm F}$ =11 A, $T_{\rm j}$ =25 °C	-	0.52	0.7	
Reverse recovery charge	Q1 Q2	$Q_{\rm rr}$	$V_{R}=12 \text{ V}, I_{F}=I_{S},$ $di_{F}/dt=100 \text{ A/}\mu\text{s}$	-	10	-	nC

<sup>&</sup>lt;sup>5)</sup> For more information see application note n° TBD <sup>6)</sup> The device can withstand a pulse of not more than 30 V for a duration of up to 2 ns at a frequency of 600 kHz with maximum buck converter input voltage  $V_{IN}$ =16 V

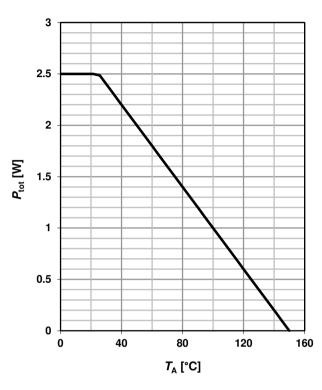


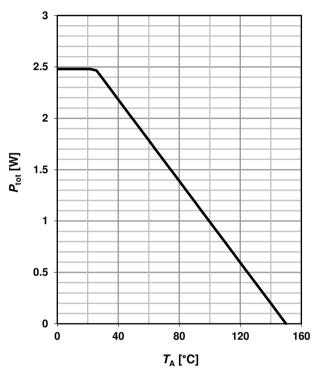
## 1 Power dissipation (Q1)

$$P_{\text{tot}} = f(T_A)^{4)}$$

# 2 Power dissipation (Q2)

$$P_{\text{tot}} = f(T_A)^{4)}$$





# 3 Drain current (Q1)

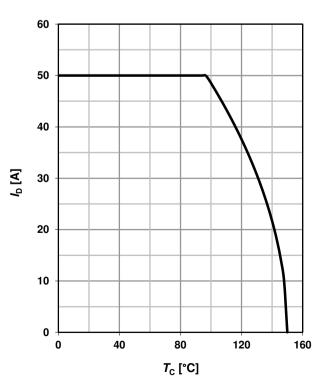
 $I_{D}=f(T_{C})$ 

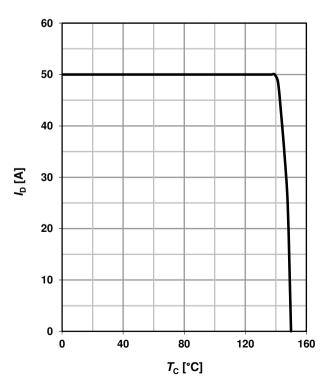
parameter: V<sub>GS</sub>≥10 V

# 4 Drain current (Q2)

 $I_{D}=f(T_{C})$ 

parameter: V<sub>GS</sub>≥10 V



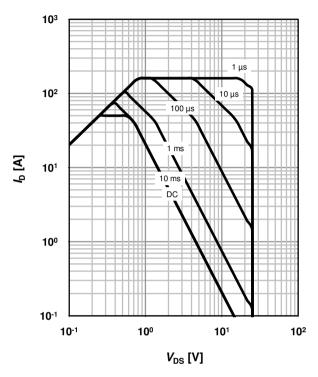




## 5 Safe operating area (Q1)

 $I_{D}=f(V_{DS}); T_{C}=25 \text{ °C}; D=0$ 

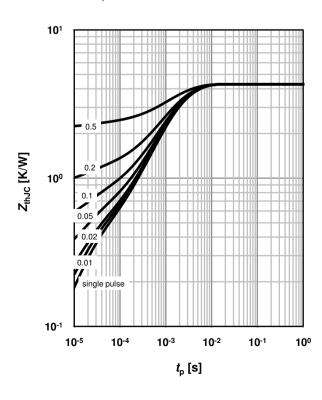
parameter:  $t_p$ 



# 7 Max. transient thermal impedance (Q1)

 $Z_{\text{thJC}} = f(t_p)$ 

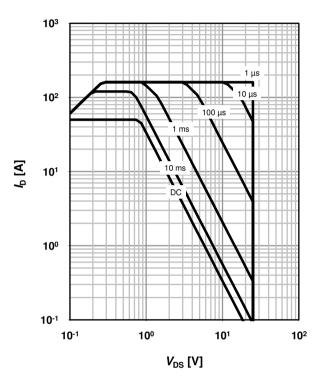
parameter:  $D = t_p/T$ 



### 6 Safe operating area (Q2)

 $I_D=f(V_{DS}); T_C=25 \text{ °C}; D=0$ 

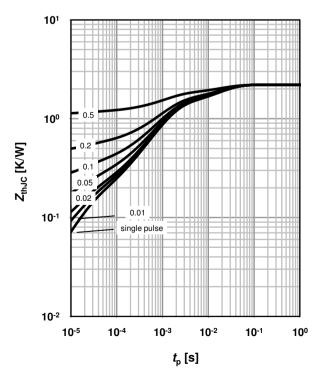
parameter: t<sub>p</sub>



### 8 Max. transient thermal impedance (Q2)

 $Z_{\text{thJC}} = f(t_p)$ 

parameter:  $D=t_p/T$ 

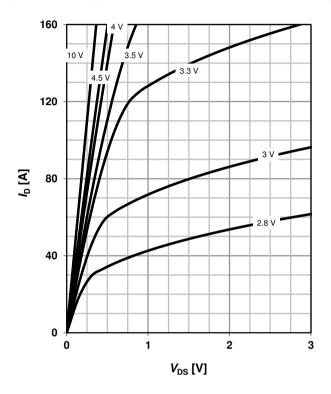




## 9 Typ. output characteristics (Q1)

 $I_D=f(V_{DS}); T_i=25 \text{ °C}$ 

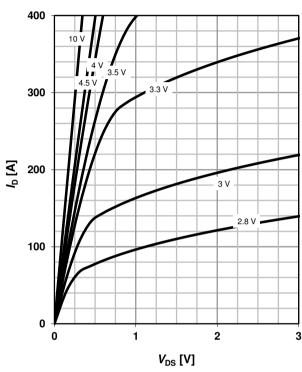
parameter: V<sub>GS</sub>



## 10 Typ. output characteristics (Q2)

 $I_D=f(V_{DS}); T_i=25 \text{ °C}$ 

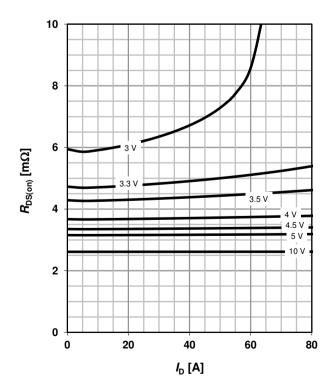
parameter: V<sub>GS</sub>



## 11 Typ. drain-source on resistance (Q1)

 $R_{DS(on)}=f(I_D); T_j=25 \text{ °C}$ 

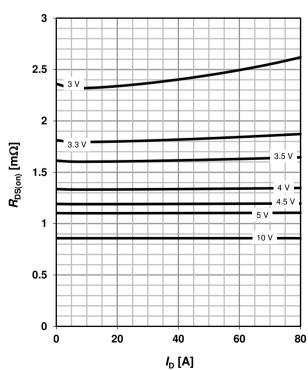
parameter: V<sub>GS</sub>



## 12 Typ. drain-source on resistance (Q2)

 $R_{DS(on)}=f(I_D); T_j=25 \text{ °C}$ 

parameter:  $V_{\rm GS}$ 

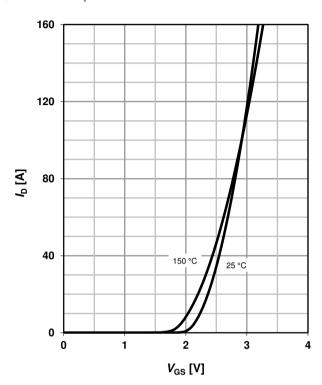




## 13 Typ. transfer characteristics (Q1)

 $I_{D}=f(V_{GS}); |V_{DS}|>2 |I_{D}| R_{DS(on)max}$ 

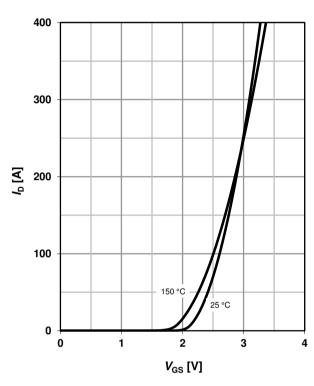
parameter: T<sub>i</sub>



### 14 Typ. transfer characteristics (Q2)

 $I_{D}=f(V_{GS}); /V_{DS} > 2 | I_{D}/R_{DS(on)max}$ 

parameter: T<sub>i</sub>

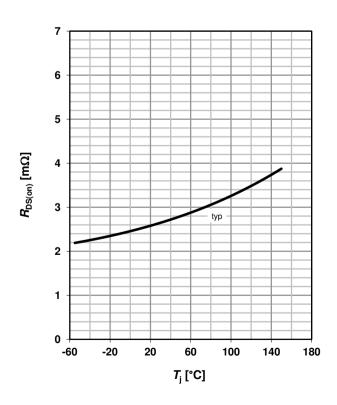


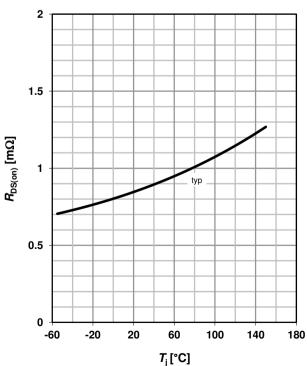
### 15 Drain-source on-state resistance (Q1)

 $R_{DS(on)}$ =f( $T_j$ );  $I_D$ =20 A;  $V_{GS}$ =10 V



$$R_{DS(on)}$$
=f( $T_j$ );  $I_D$ =20 A;  $V_{GS}$ =10 V





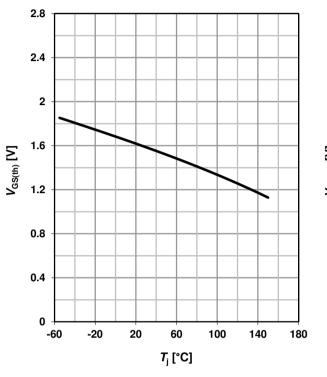


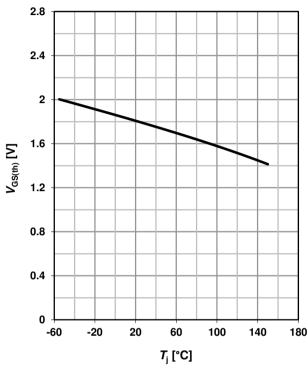
### 17 Typ. gate threshold voltage (Q1)

# $V_{GS(th)} = f(T_i); V_{GS} = V_{DS}; I_D = 250 \mu A$

## 18 Typ. gate threshold voltage (Q2)

$$V_{GS(th)}=f(T_i); V_{GS}=V_{DS}; I_D=10 \text{ mA}$$



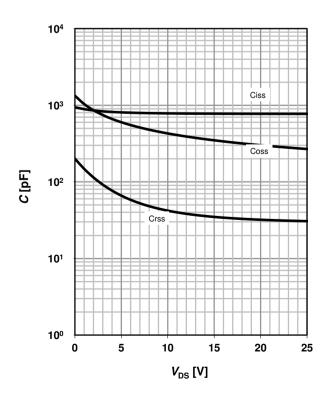


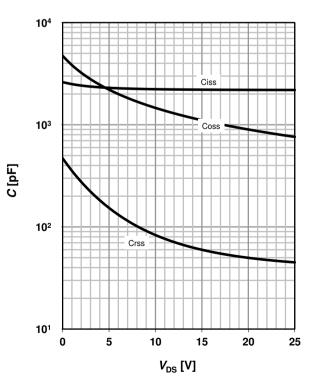
## 19 Typ. capacitances (Q1)

 $C=f(V_{DS}); V_{GS}=0 V; f=1 MHz$ 

## 20 Typ. capacitances (Q2)

$$C=f(V_{DS}); V_{GS}=0 V; f=1 MHz$$



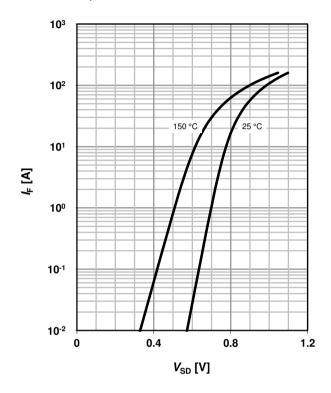




### 21 Forward characteristics of reverse diode (Q1) 22 Forward characteristics of reverse diode (Q2)

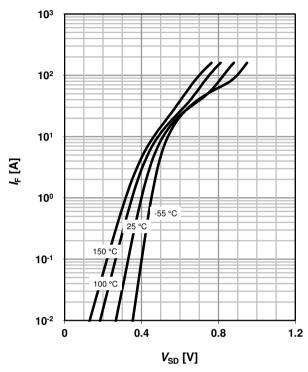
### $I_{\mathsf{F}} = \mathsf{f}(V_{\mathsf{SD}})$

parameter: T<sub>i</sub>



 $I_{\mathsf{F}} = \mathsf{f}(V_{\mathsf{SD}})$ 

parameter: T<sub>i</sub>



## 23 Avalanche characteristics (Q1)

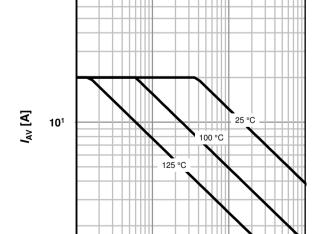
 $I_{AS}$ =f( $t_{AV}$ );  $R_{GS}$ =25  $\Omega$ 

parameter:  $T_{j(start)}$ 

10<sup>2</sup>

**10**º

**10**º



10¹

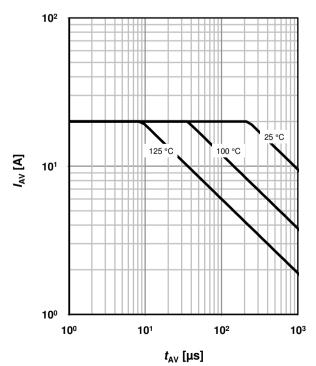
10<sup>2</sup>

*t*<sub>AV</sub> [μs]

### 24 Avalanche characteristics (Q2)

 $I_{AS}$ =f( $t_{AV}$ );  $R_{GS}$ =25  $\Omega$ 

parameter:  $T_{j(start)}$ 



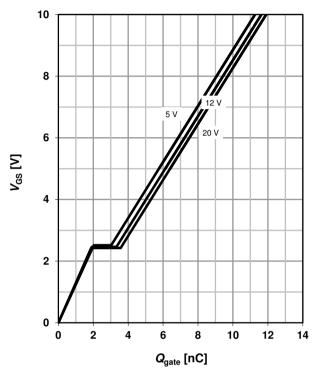
10³



### 25 Typ. gate charge (Q1)

 $V_{GS}$ =f( $Q_{gate}$ );  $I_D$ =20 A pulsed

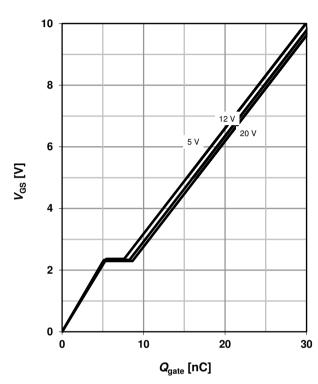
parameter: V<sub>DD</sub>



## 26 Typ. gate charge (Q2)

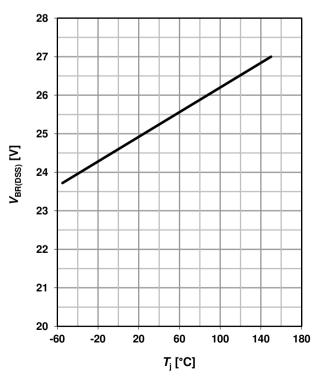
 $V_{GS}$ =f( $Q_{gate}$ );  $I_D$ =20 A pulsed

parameter:  $V_{\rm DD}$ 



### 27 Drain-source breakdown voltage (Q1)

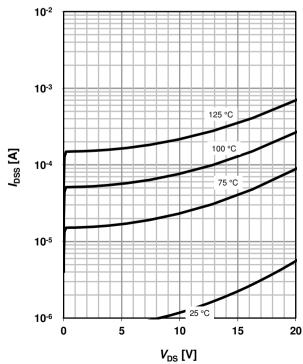
 $V_{BR(DSS)}=f(T_j); I_D=1 \text{ mA}$ 



### 28 Typ. drain-source leakage current (Q2)

 $I_{DSS}=f(V_{DS}); V_{GS}=0 V$ 

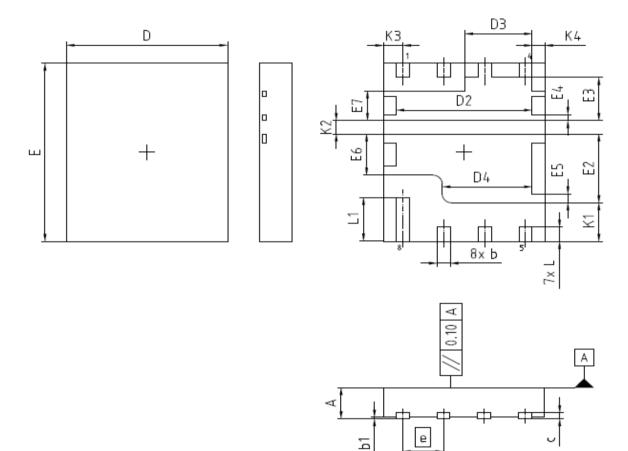
parameter:  $T_{\rm j}$ 





## **Package Outline**

## PG-TISON8-4



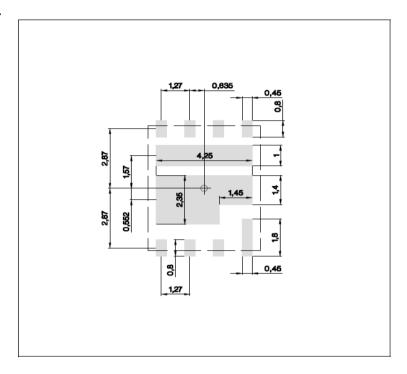
DIM	MILLIM	ETERS	INC	HES
DIM	MIN	MAX	MIN	MAX
A	0.90	1.15	0.035	0.045
ь	0.31	0.51	0.012	0.020
ь1	0.00	0.05	0.000	0.002
С	0.10	0.30	0.004	0.012
D	4.90	5.10	0.193	0201
D2	4.12	4.32	0.162	0.170
D3	1.99	2.19	0.078	0.086
D4	2.69	2.89	0.106	0.114
E	5.90	6.10	0.232	0.240
E2	2.22	2.42	0.087	0.095
E3	1.35	1.55	0.053	0.061
E4	0.10	0.30	0.004	0.012
E5	020	0.40	0.008	0.016
E6	1 29	1.49	0.051	0.059
E7	0.90	1.10	0.035	0.043
e	1.27 (	BSC)	0.05 (	BSC)
N		3	8	3
L	0.38	0.58	0.015	0.023
L1	1.38	1.58	0.054	0.062
K1	1 20	1.40	0.047	0.055
K2	0.35	0.55	0.014	0.022
K3	0.50	0.70	0.020	0.028
K4	029	0.49	0.011	0.019

DOCUMENT NO.
Z8 B00176527
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EURO PEAN PROJECTION
ISSUE DATE 13-03-2015
REVISION 01

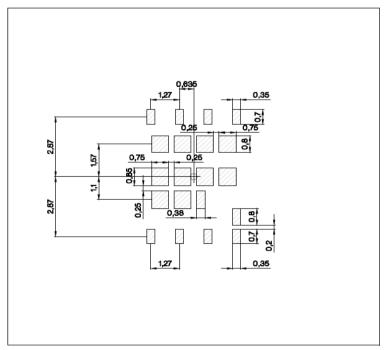


## **Boardpads & Apertures**

## PG-TISON8-4



## copper



stencil apertures
All the dimensions in mm

# 25V OptiMOS™5 Power MOSFET

### BSG0813NDI



### **Revision History**

BSG0813NDI

Revision: 2016-03-24, Rev. 2.1

### **Previous Revision**

Revision	Date	ubjects (major changes since last revision)			
2.0	2015-03-17	Release of final version			
2.1	2016-03-24	Update package drawing			

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### Warnings

Due to technical requirements, components may contain dangerous substances. For information on the types in question, please contact the nearest Infineon Technologies Office.

The Infineon Technologies component described in this Data Sheet may be used in life-support devices or systems and/or automotive, aviation and aerospace applications or systems only with the express written approval of Infineon Technologies, if a failure of such components can reasonably be expected to cause the failure of that life-support, automotive, aviation and aerospace device or system or to affect the safety or effectiveness of that device or system. Life support devices or systems are intended to be implanted in the human body or to support and/or maintain and sustain and/or protect human life. If they fail, it is reasonable to assume that the health of the user or other persons may be endangered.